

**Search Notes**

Application/Control No.

10/523,124

Examiner

Mark Hellner

Applicant(s)/Patent under  
Reexamination

YIN, HEZHU

Art Unit

3663

**SEARCHED**

Class	Subclass	Date	Examiner
357	38	10/30/2006	MH
702	14, 17	10/30/2006	MH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Interference search	10/30/2006	MH